



SLP80P06T -60V P -Channel MOSFET

General Description

This Power MOSFET is produced using Msemitek's advanced TRENCH technology.

This advanced technology has been especially tailored to minimize conduction loss, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

Application

☑PWM Application

☑Power Management

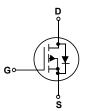
Features

- P-Channel: -60V - 80A

 $R_{DS(on)Typ} = 17.5m\Omega@V_{GS} = -10 \text{ V}$ $R_{DS(on))Typ} = 19m\Omega@V_{GS} = -4.5 \text{ V}$

- Very Low On-resistance R_{DS(ON)}
- Low Crss
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability





Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter	SLP80P06T	Units
V_{DSS}	Drain-Source Voltage	-60	V
	Drain Current - Continuous (T _C = 25°C)	-80	Α
I _D	- Continuous (T _C = 100°C)	-64	Α
I _{DM}	Drain Current - Pulsed (Note 1)	-320	Α
V_{GSS}	Gate-Source Voltage	±20	V
E _{AS}	Single Pulsed Avalanche Energy (Note 2)	756	mJ
P _D	Power Dissipation (T _C = 25°C)	240	W
R _{0JC}	Thermal Resistance, Junction to Case	0.53	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range	-55 to +150	°C
T∟	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	°C

^{*} Drain current limited by maximum junction temperature.

Package Marking

Part Number	Top Marking	Package	Packing Method	MOQ	QTY
SLP80P06T	SLP80P06T	TO-220C	Tube	1000	5000

Electrical Characteristics

 T_C = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units		
Off Characteristics								
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = -250 \text{ uA}$	-60			V		
l	Zero Gate Voltage Drain Current	V _{DS} = -60 V, V _{GS} = 0 V			-1	uA		
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -48V, T_{C} = 125^{\circ}C$			-10	uA		
I _{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = 20V, V_{DS} = 0 V$			100	nA		
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -20V, V_{DS} = 0 V$			-100	nA		

On Characteristics

$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_{D} = -250 \text{ uA}$	-1.1	-1.6	-2.2	V
R _{DS(on)}	Static Drain-Source	V _{GS} = -10 V, I _D = -20A	17.5	20	0	
	On-Resistance	$V_{GS} = -4.5 \text{ V}, I_D = -20 \text{A}$	-	19	22	mΩ

Dynamic Characteristics

C _{iss}	Input Capacitance	V _{DS} = -20 V, V _{GS} = 0 V, f = 1.0 MHz	1	4400	-	pF
Coss	Output Capacitance		1	259	1	pF
C_{rss}	Reverse Transfer Capacitance	1.0 WHZ		212	-	pF

Switching Characteristics

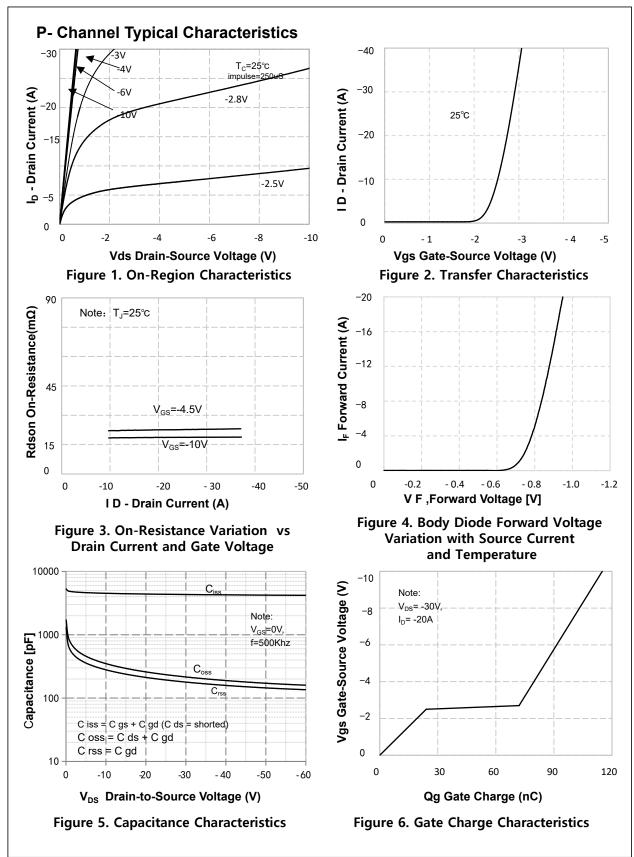
$t_{d(on)}$	Turn-On Delay Time		(Note 3)			24	 ns
tr	Turn-On Rise Time	V_{GS} = -10 V, V_{DS} = -30 V, R_{G} =1 Ω , I_{D} = -20A		-	18	 ns	
$t_{d(off)}$	Turn-Off Delay Time			-	56	 ns	
t _f	Turn-Off Fall Time			-	30	 ns	
Q_g	Total Gate Charge	V _{DS} = -30 V, I _D = -20A, V _{GS} = -10V		-	115	 nC	
Q_{gs}	Gate-Source Charge		(Note 3)	-	27.4	 nC	
Q_{gd}	Gate-Drain Charge			-	50	 nC	

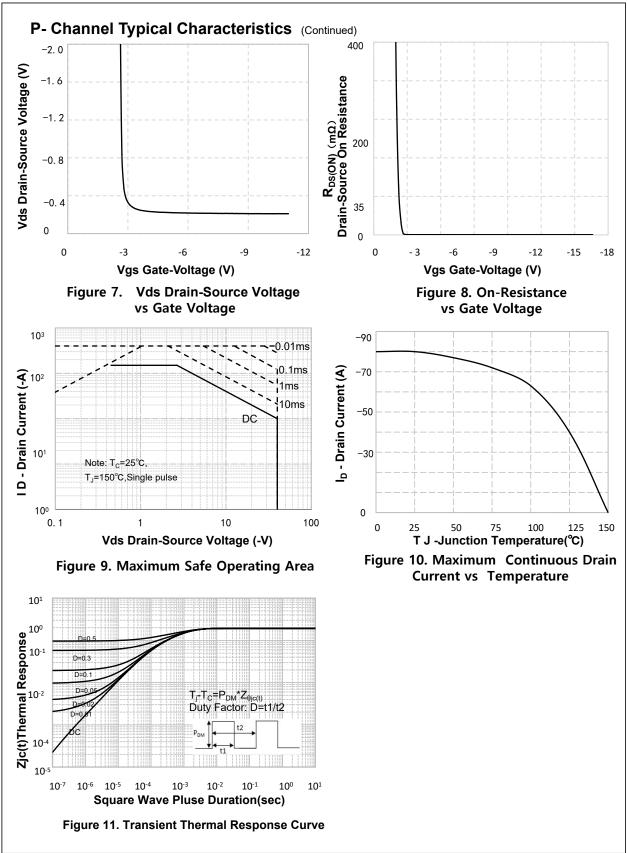
Drain-Source Diode Characteristics and Maximum Ratings

Is	Maximum Continuous Drain-Source Diode Forward Current	 	-80	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current	 	-320	Α
V_{SD}	Drain to Source Diode Forward Voltage, V _{GS} = 0V, I _{SD} = -20A, TJ = 25°C	 	-1.2	V
t _{rr}	Reverse Recovery Time T J = 25°C, IF =-20A,di/dt =100A/µs	 117	-	nS
Qrr	Reverse Recovery Charge T J = 25°C, IF =-20A,di/dt =100A/µs	 420	-	nC

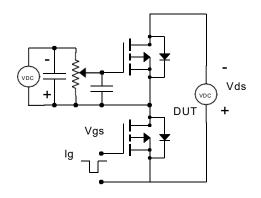
Notes:

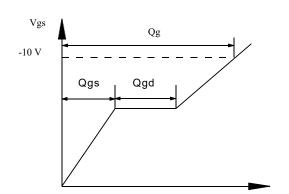
- 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
- 2. EAS condition: TJ = 25°C, VDD =-25V, VG = -5V, RG =25 Ω , L=0.5mH
- 3. Pulse Test: Pulse Width≤300 μ s, Duty Cycle≤0.5%



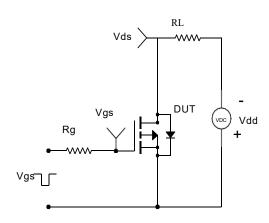


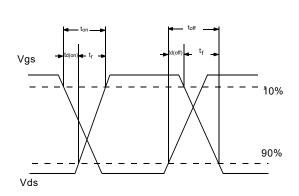
Gate Charge Test Circuit & Waveform



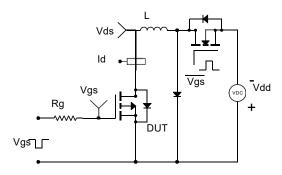


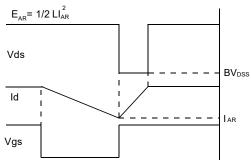
Resistive Switching Test Circuit & Waveforms



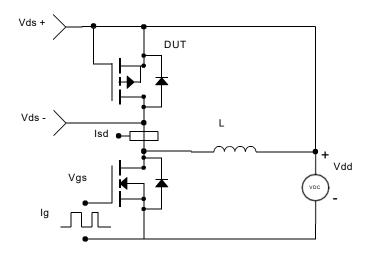


Unclamped Inductive Switching Test Circuit & Waveforms

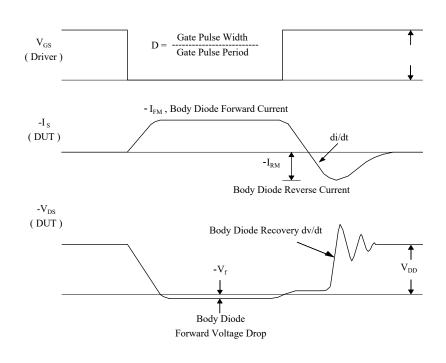




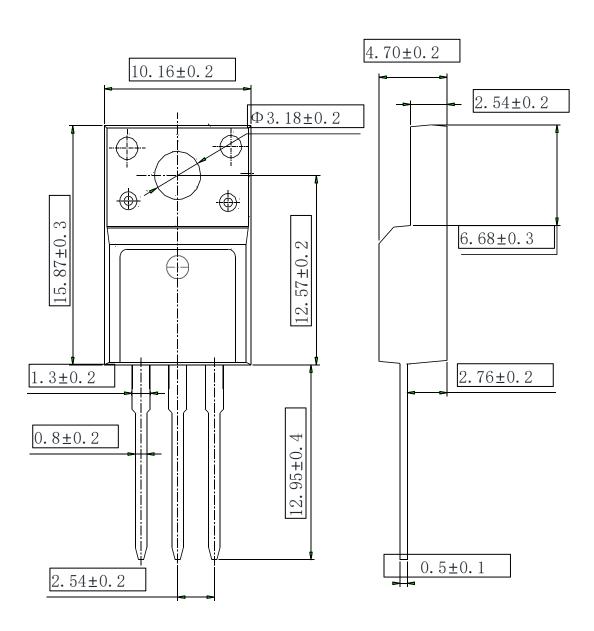
Peak Diode Recovery dv/dt Test Circuit & Waveforms



- dv/dt controlled by RG
- Isd controlled by pulse period



TO-220F OUTLINE



NOTE:

1The plastic package is not marked as smooth surfaceRa=0.1;Subglossy surfaceRa=0.8 2.Undeclared tolerance \pm 0.15,Unmarked filletRmax=0.25

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